

**Search Notes**

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Examiner

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Applicant(s)/Patent under  
Reexamination

CHENG ET AL.

Art Unit

2618

**SEARCHED**

Class	Subclass	Date	Examiner
455	23, 42, 65	7/19/2007	ST
455	61, 102	7/19/2007	ST
455	506, 295	7/19/2007	ST
375	219, 260	7/19/2007	ST
375	261-262	7/19/2007	ST
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370	212-215	7/19/2007	ST
370	483	7/19/2007	ST

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
455	65	7/19/2007	ST
375	295	7/19/2007	ST
375	340	7/19/2007	ST

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
U.S. Patent, EPO, JPO, DERWENT, PG-PUB	7/19/2007	ST